# **DISCRETE SEMICONDUCTORS**

# DATA SHEET

**PEMD12; PUMD12** NPN/PNP resistor-equipped transistors; R1 = 47 kΩ, R2 = 47 kΩ

Product data sheet Supersedes data of 2001 Nov 7 2003 Oct 08



# NPN/PNP resistor-equipped transistors; R1 = 47 k $\Omega$ , R2 = 47 k $\Omega$

PEMD12; PUMD12

#### **FEATURES**

- Built-in bias resistors
- · Simplified circuit design
- · Reduction of component count
- · Reduced pick and place costs.

## **APPLICATIONS**

- · Low current peripheral driver
- Replacement of general purpose transistors in digital applications
- . Control of IC inputs.

#### QUICK REFERENCE DATA

SYMBOL	PARAMETER	TYP.	MAX.	UNIT
$V_{CEO}$	collector-emitter voltage	_	50	V
Io	output current (DC)	_	100	mA
TR1	NPN	_	-	-
TR2	PNP	_	_	_
R1	bias resistor	47		kΩ
R2	bias resistor	47	-	kΩ

#### **DESCRIPTION**

NPN/PNP resistor-equipped transistors (see "Simplified outline, symbol and pinning" for package details).

#### **PRODUCT OVERVIEW**

TYPE	PAC	(AGE	MARKING CODE	PNP/PNP	NPN/NPN
NUMBER	PHILIPS	EIAJ	WARKING CODE	COMPLEMENT	COMPLEMENT
PEMD12	SOT666		D2	PEMB2	PEMH2
PUMD12	SOT363	SC-88	D*1 <sup>(1)</sup>	PUMB2	PUMH2

## Note

- 1. \* = p: Made in Hong Kong.
  - \* = t: Made in Malaysia.
  - \* = W: Made in China.

## SIMPLIFIED OUTLINE, SYMBOL AND PINNING

TYPE NUMBER	SIMPLIFIED OUTLINE AND SYMBOL		PINNING
TIPE NOWIBER	SIMIFLIFIED OUTLINE AND STRIBOL	PIN	DESCRIPTION
PEMD12	6 5 4	1	emitter TR1
PUMD12		2	base TR1
	R1 R2	3	collector TR2
	TR2	4	emitter TR2
		5	base TR2
	$\left[\begin{array}{c c} & & & \\ & & & \end{array}\right]$ R1	6	collector TR1
	1 2 3		
	1 2 3 Top view 1 2 3		

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## **ORDERING INFORMATION**

TYPE NUMBER		PACKAGE					
TIPE NOWBER	NAME	DESCRIPTION	VERSION				
PEMD12	_	plastic surface mounted package; 6 leads	SOT666				
PUMD12	_	plastic surface mounted package; 6 leads	SOT363				

## **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT			
Per transist	Per transistor; for the PNP transistor with negative polarity							
V <sub>CBO</sub>	collector-base voltage	open emitter	_	50	V			
V <sub>CEO</sub>	collector-emitter voltage	open base	_	50	V			
V <sub>EBO</sub>	emitter-base voltage	open collector	-	10	V			
VI	input voltage TR1							
	positive		_	+40	V			
	negative		_	-10	V			
V <sub>I</sub>	input voltage TR2							
	positive		_	+10	V			
	negative		_	-40	V			
I <sub>O</sub>	output current (DC)		_	100	mA			
I <sub>CM</sub>	peak collector current		_	100	mA			
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C						
	SOT363	note 1	_	200	mW			
	SOT666	notes 1 and 2	_	200	mW			
T <sub>stg</sub>	storage temperature		-65	+150	°C			
Tj	junction temperature		-	150	°C			
T <sub>amb</sub>	operating ambient temperature		-65	+150	°C			
Per device								
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C						
	SOT363	note 1	_	300	mW			
	SOT666	notes 1 and 2	_	300	mW			

#### **Notes**

- 1. Device mounted on an FR4 printed-circuit board, single-sided copper, standard footprint.
- 2. Reflow soldering is the only recommended soldering method.

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## THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
Per transist	or			
R <sub>th j-a</sub>	thermal resistance from junction to ambient	T <sub>amb</sub> ≤ 25 °C		
	SOT363	note 1	625	K/W
	SOT666	notes 1 and 2	625	K/W
Per device				
R <sub>th j-a</sub>	thermal resistance from junction to ambient	T <sub>amb</sub> ≤ 25 °C		
	SOT363	note 1	416	K/W
	SOT666	notes 1 and 2	416	K/W

#### **Notes**

- 1. Device mounted on an FR4 printed-circuit board, single-sided copper, standard footprint.
- 2. Reflow soldering is the only recommended soldering method.

#### **CHARACTERISTICS**

 $T_{amb}$  = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Per transis	stor; for the PNP transistor with ne	gative polarity		•	•	•
I <sub>CBO</sub>	collector-base cut-off current	V <sub>CB</sub> = 50 V; I <sub>E</sub> = 0	_	_	100	nA
I <sub>CEO</sub>	collector-emitter cut-off current	V <sub>CE</sub> = 30 V; I <sub>B</sub> = 0	_	_	1	μΑ
		V <sub>CE</sub> = 30 V; I <sub>B</sub> = 0; T <sub>j</sub> = 150 °C	_	_	50	μА
I <sub>EBO</sub>	emitter-base cut-off current	V <sub>EB</sub> = 5 V; I <sub>C</sub> = 0	_	_	90	μΑ
h <sub>FE</sub>	DC current gain	V <sub>CE</sub> = 5 V; I <sub>C</sub> = 5 mA	80	_	_	
V <sub>CEsat</sub>	collector-emitter saturation voltage	$I_C = 10 \text{ mA}; I_B = 0.5 \text{ mA}$	_	_	150	mV
V <sub>i(off)</sub>	input-off voltage	I <sub>C</sub> = 100 μA; V <sub>CE</sub> = 5 V	_	1.2	0.8	V
V <sub>i(on)</sub>	input-on voltage	$I_C = 2 \text{ mA}; V_{CE} = 0.3 \text{ V}$	3	1.6	_	V
R1	input resistor		33	47	61	kΩ
R2 R1	resistor ratio		0.8	1	1.2	
C <sub>c</sub>	collector capacitance	$I_E = i_e = 0$ ; $V_{CB} = 10 \text{ V}$ ; $f = 1 \text{ MHz}$				
	TR1 (NPN)		_	_	2.5	pF
	TR2 (PNP)		_	_	3	pF

2003 Oct 08

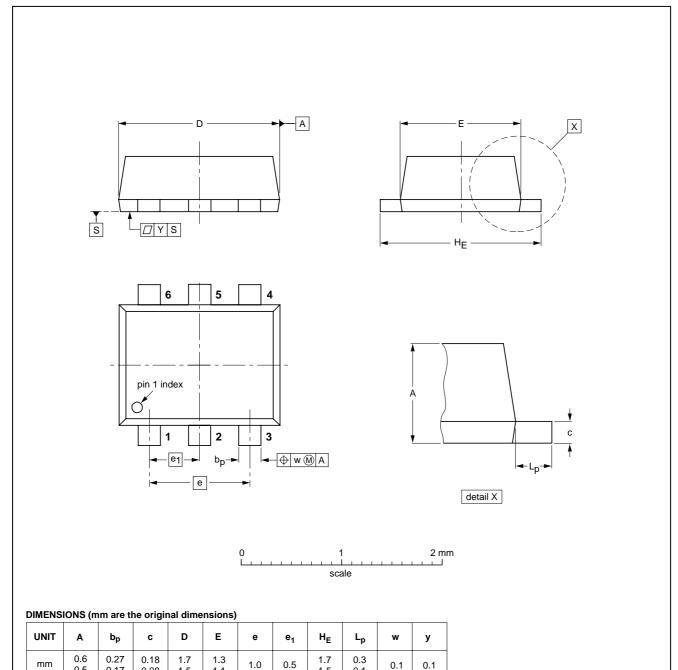
# NPN/PNP resistor-equipped transistors; R1 = 47 k $\Omega$ , R2 = 47 k $\Omega$

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## **PACKAGE OUTLINES**

Plastic surface mounted package; 6 leads

SOT666



OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION			EIAJ		PROJECTION	1330E DATE
SOT666						<del>01-01-04</del> 01-08-27

1.5

2003 Oct 08 5

0.17

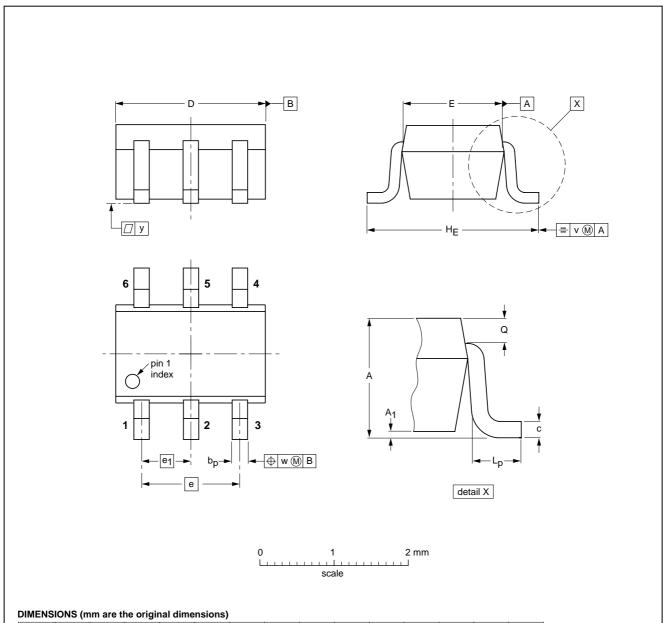
0.08

# NPN/PNP resistor-equipped transistors; R1 = 47 k $\Omega$ , R2 = 47 k $\Omega$

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## Plastic surface mounted package; 6 leads

**SOT363** 



UNIT	Α	A <sub>1</sub> max	bp	С	D	E	е	e <sub>1</sub>	HE	Lp	Q	v	w	у
mm	1.1 0.8	0.1	0.30 0.20	0.25 0.10	2.2 1.8	1.35 1.15	1.3	0.65	2.2 2.0	0.45 0.15	0.25 0.15	0.2	0.2	0.1

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT363			SC-88			97-02-28

# NPN/PNP resistor-equipped transistors; R1 = 47 k $\Omega$ , R2 = 47 k $\Omega$

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#### **DATA SHEET STATUS**

DOCUMENT STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

#### **Notes**

- 1. Please consult the most recently issued document before initiating or completing a design.
- 2. The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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## **Customer notification**

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## **Contact information**

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